











#### REF5020-EP, REF5025-EP, REF5040-EP, REF5050-EP

SBOS471B - APRIL 2010 - REVISED JUNE 2015

# REF50xx-EP Low-Noise, Very Low Drift, Precision Voltage Reference

### **Features**

- Low Temperature Drift: 5 ppm/°C (Maximum)
- High Accuracy: 0.08% (Maximum)
- Low Noise: 3 µV<sub>PP</sub>/V
- High Output Current: ±10 mA
- Available in Military (-55°C to 125°C) Temperature Range (1)
- Extended Product Life Cycle
- **Extended Product-Change Notification**
- **Product Traceability**

## **Applications**

- 16-Bit Data Acquisition Systems
- ATE Equipment
- **Industrial Process Control**
- Medical Instrumentation
- **Optical Control Systems**
- **Precision Instrumentation**
- Controlled Baseline
- One Assembly/Test Site
- One Fabrication Site
- Custom temperature ranges available

## 3 Description

The REF50xx is a family of low-noise, very low-drift, very high precision voltage references. These references are capable of both sinking and sourcing, and are very robust with regard to line and load changes.

Excellent temperature drift and high accuracy are achieved using proprietary design techniques. These features, combined with very low noise, make the REF50xx family ideal for use in high-precision data acquisition systems.

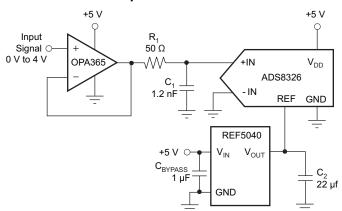
They are offered in SOIC-8 packages, and are specified from -55°C to 125°C.

### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)	
REF50xx-EP	SOIC (8)	4.90 mm × 3.91 mm	

(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### Simplified Schematic





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## 4 Revision History

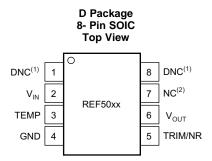
## Changes from Revision A (October 2012) to Revision B

**Page** 

•	Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and	
	Mechanical, Packaging, and Orderable Information section	. 3
•	Changed title of Supply Voltage to Low Dropout Voltage	19



## 5 Pin Configuration and Functions



NOTES: (1) DNC = Do not connect. (2) NC = No internal connection.

#### **Pin Functions**

PIN		1/0	DECORPTION			
NAME	NO.	1/0	DESCRIPTION			
DNC	1	_	Do not connect			
VIN	2	Power	Power supply voltage. Range from V $_{OUT}$ + 0.2 V up to 18 V. Recommended bypass capacitor from 1 $\mu F$ up to 10 $\mu F$			
TEMP	3	0	Temperature monitoring pin provides a temperature-dependent voltage output			
GND	4	Power	System ground			
TRIM/NR	5	I	Output adjustment and noise reduction input. Connecting 1 $\mu F$ to this pin will create low pas filter at the bandgap and reduce output noise			
VOUT	6	0	Very accurate, factory-trimmed voltage output. Recommended bypass capacitor from 1 $\mu F$ up to 50 $\mu F$ with ESR between 1 and 1.5 $\Omega$			
NC	7	_	No internal connection			
DNC	8	_	Do not connect			

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)(1)

	MIN	MAX	UNIT
Input voltage V <sub>IN</sub>		18	V
Output short-circuit		30	mA
Operating temperature	<b>-</b> 55	125	°C
Junction temperature, T <sub>J</sub>		150	°C
Storage temperature, T <sub>stg</sub>	-65	150	°C

<sup>(1)</sup> Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

### 6.2 ESD Ratings

			VALUE	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 (1)	±3000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1000	V

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



## 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

	MIN	MAX	UNIT
V <sub>IN</sub>	V <sub>OUT</sub> + 0.2 V	18	V
lout	-10	10	mA

## 6.4 Thermal Information

		REF502x-EP	
	THERMAL METRIC <sup>(1)</sup>	D (SOIC)	UNIT
		8 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	97.1	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	42.2	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	34.6	°C/W

For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

### 6.5 Electrical Characteristics: Per Device

At  $T_A = 25$ °C,  $I_{LOAD} = 0$ ,  $C_L = 1 \mu F$ , and  $V_{IN} = (V_{OUT} + 0.2 \text{ V})$  to 18 V, unless otherwise noted.

DADAMETE	n	TEST CONDITIONS	T <sub>A</sub> = 25°C			T <sub>A</sub> = -55°C to 125°C			UNIT
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNI
REF5020 (V <sub>OUT</sub> = 2.048V)	(1)	·			•			•	
OUTPUT VOLTAGE									
Output Voltage	V <sub>OUT</sub>	2.7 V < V <sub>IN</sub> < 18 V		2.048					V
Initial Accuracy			-0.05%		0.05%				
Over Temperature						-0.08%		0.08%	
NOISE									
Output Voltage Noise		f = 0.1 Hz to 10 Hz		6					$\mu V_{PF}$
REF5025 (V <sub>OUT</sub> = 2.5 V)		•	•		•			•	
OUTPUT VOLTAGE									
Output Voltage	V <sub>OUT</sub>			2.5					V
Initial Accuracy			-0.05%		0.05%				
NOISE					1				
Output Voltage Noise		f = 0.1 Hz to 10 Hz		7.5					μV <sub>PF</sub>
REF5040 (V <sub>OUT</sub> = 4.096V)					1				
OUTPUT VOLTAGE									
Output Voltage	V <sub>OUT</sub>			4.096					V
Initial Accuracy			-0.05%		0.05%				
Over Temperature						-0.08%		0.08%	
NOISE									
Output Voltage Noise		f = 0.1 Hz to 10 Hz		12					$\mu V_{PF}$
REF5050 (V <sub>OUT</sub> = 5 V)					1				
OUTPUT VOLTAGE									
Output Voltage	V <sub>OUT</sub>			5					V
Initial Accuracy			-0.05%		0.05%				
Over Temperature						-0.08%		0.08%	
NOISE		·	•						
Output Voltage Noise		f = 0.1 Hz to 10 Hz		15					μV <sub>PF</sub>

<sup>(1)</sup> For  $V_{OUT} \le 2.5 \text{ V}$ , the minimum supply voltage is 2.7 V.



### 6.6 Electrical Characteristics: All Devices

At  $T_A = 25$ °C,  $I_{LOAD} = 0$ ,  $C_L = 1 \mu F$ , and  $V_{IN} = (V_{OUT} + 0.2 \text{ V})$  to 18 V, unless otherwise noted.

PARAMETER		TEST COMPITIONS	T <sub>A</sub> = 25°C			T <sub>A</sub> = -55°C to 125°C			UNIT
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNII
OUTPUT VOLTAGE TEMPERATU	JRE DRIFT								
Output Voltage Temperature Drift	dV <sub>OUT</sub> /dT								
REF5025							4	6.5	ppm/°C
REF5050							4	6.5	ppm/°C
All other devices							3	5	ppm/°C
LINE REGULATION									
Line Regulation	dV <sub>OUT</sub> /dV <sub>IN</sub>								
REF5020 <sup>(1)</sup>		V <sub>IN</sub> = 2.7 V to 18V		0.1	1				ppm/V
All other devices		V <sub>IN</sub> = V <sub>OUT</sub> + 0.2 V		0.1	1				ppm/V
Over Temperature							1	3	ppm/V
LOAD REGULATION					*			•	
Load Regulation	dV <sub>OUT</sub> /d <sub>ILOAD</sub>								
REF5020		$-10 \text{ mA} < I_{LOAD} < +10 \text{ mA}, V_{IN} = 3 \text{ V}$		20	30				ppm/mA
All other devices		$-10 \text{ mA} < I_{LOAD} < +10 \text{ mA}, V_{IN} = V_{OUT} + 0.75 \text{ V}$		20	30				ppm/mA
Over Temperature								60	ppm/mA
SHORT-CIRCUIT CURRENT									
Short-Circuit Current	I <sub>SC</sub>	V <sub>OUT</sub> = 0		25					mA
TEMP PIN									
Voltage Output		At T <sub>A</sub> = 25°C		575					mV
Temperature Sensitivity							2.64		mV/°C
TURNON SETTLING TIME		•	•		<u> </u>			•	
Turnon Settling Time		To 0.1% with $C_L = 1 \mu F$		200					μs
POWER SUPPLY									
Supply Voltage	V <sub>IN</sub>	See Note (1)	V <sub>OUT</sub> + 0.2 <sup>(1)</sup>		18				V
Quiescent Current				0.8	1				mA
Over Temperature								1.25	mA
TEMPERATURE RANGE									
Specified Range			-55		125				°C
Operating Range			-55		125				°C
Thermal Resistance	$\theta_{JA}$			150					°C/W

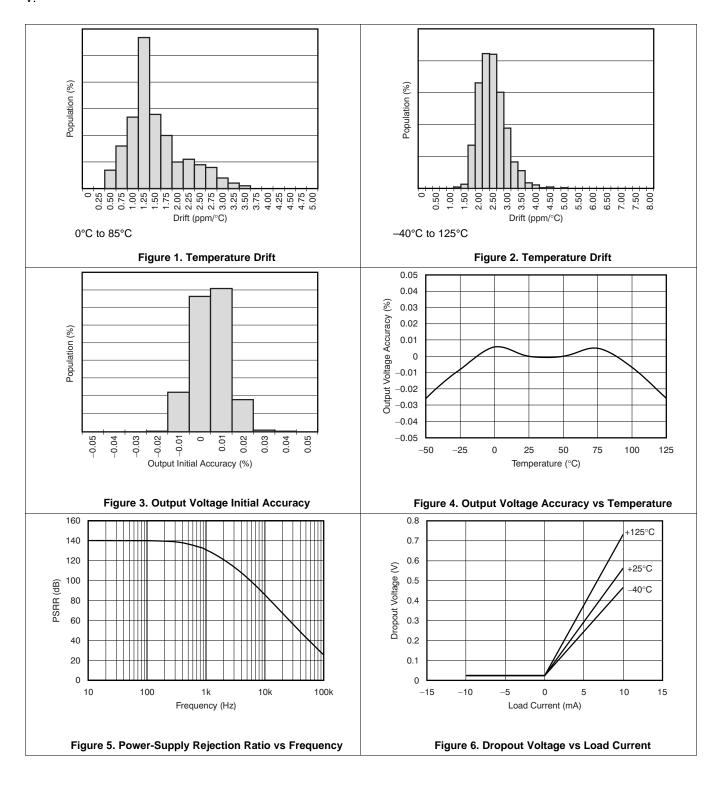
<sup>(1)</sup> For  $V_{OUT} \le 2.5 \text{ V}$ , the minimal supply voltage is 2.7 V.

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### 6.7 Typical Characteristics

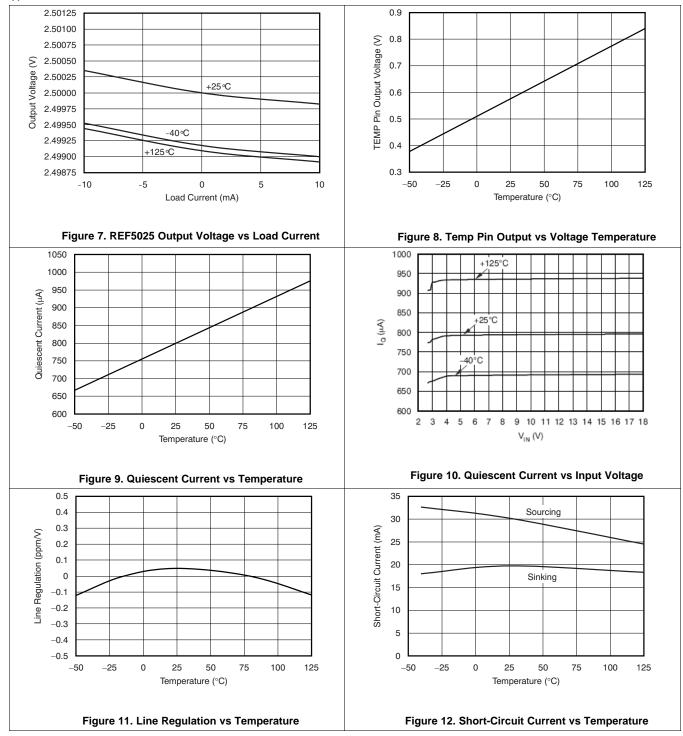
At  $T_A = 25$ °C,  $I_{LOAD} = 0$ , and  $V_{IN} = V_{OUT} + 0.2$  V, unless otherwise noted. For  $V_{OUT} \le 2.5$  V, the minimum supply voltage is 2.7 V





## **Typical Characteristics (continued)**

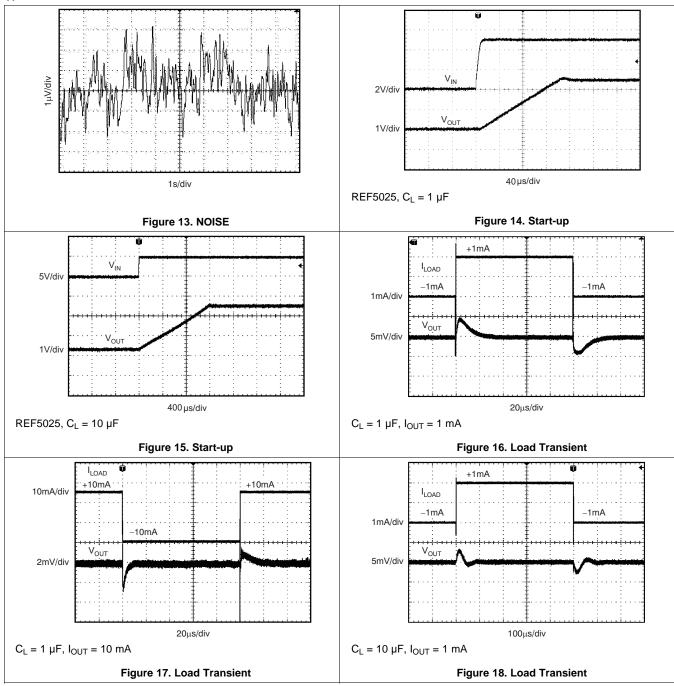
At  $T_A = 25^{\circ}\text{C}$ ,  $I_{LOAD} = 0$ , and  $V_{IN} = V_{OUT} + 0.2 \text{ V}$ , unless otherwise noted. For  $V_{OUT} \le 2.5 \text{ V}$ , the minimum supply voltage is 2.7 V.





## **Typical Characteristics (continued)**

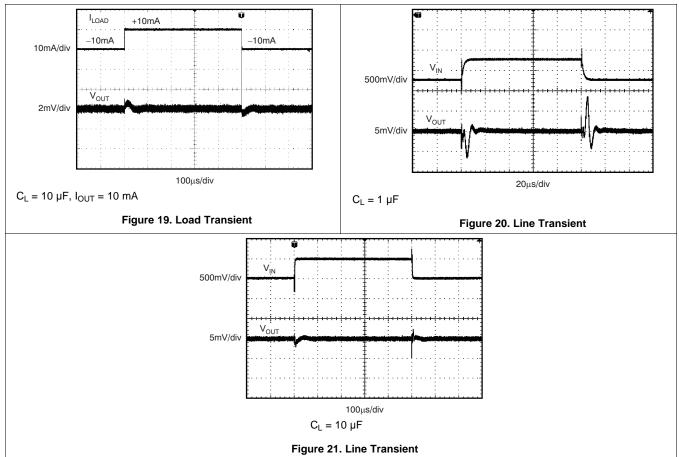
At  $T_A = 25$ °C,  $I_{LOAD} = 0$ , and  $V_{IN} = V_{OUT} + 0.2$  V, unless otherwise noted. For  $V_{OUT} \le 2.5$  V, the minimum supply voltage is 2.7 V.





## **Typical Characteristics (continued)**

At  $T_A = 25$ °C,  $I_{LOAD} = 0$ , and  $V_{IN} = V_{OUT} + 0.2$  V, unless otherwise noted. For  $V_{OUT} \le 2.5$  V, the minimum supply voltage is 2.7 V.



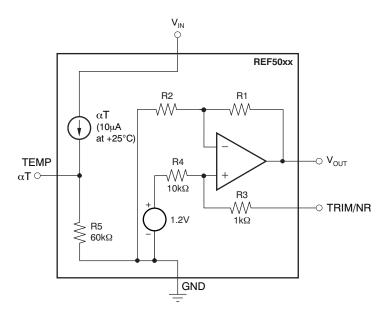


## 7 Detailed Description

#### 7.1 Overview

The REF50xx devices are low-noise, low-drift, very high precision voltage references. These references can both sink and source, and are very robust with regard to line and load changes.

### 7.2 Functional Block Diagram



### 7.3 Feature Description

### 7.3.1 Output Adjustment Using The TRIM/NR Pin

The REF50xx provides a very accurate, factory-trimmed voltage output. However,  $V_{OUT}$  can be adjusted using the trim and noise reduction pin (TRIM/NR, pin 5). Figure 22 shows a typical circuit that allows an output adjustment of  $\pm 15$  mV

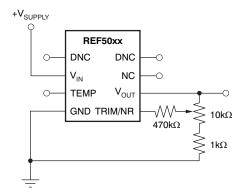


Figure 22. V<sub>OUT</sub> Adjustment Using the TRIM/NR Pin

The REF50xx allows access to the bandgap through the TRIM/NR pin. Placing a capacitor from the TRIM/NR pin to GND (see Figure 24) in combination with the internal  $R_3$  and  $R_4$  resistors creates a low-pass filter. A capacitance of 1  $\mu$ F creates a low-pass filter with the corner frequency between 10 Hz and 20 Hz. Such a filter decreases the overall noise measured on the  $V_{OUT}$  pin by half. Higher capacitance results in a lower filter cutoff frequency, further reducing output noise. Use of this capacitor increases start-up time.

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### Feature Description (continued)

#### 7.3.2 Low Temperature Drift

The REF50xx is designed for minimal drift error, which is defined as the change in output voltage over temperature. The drift is calculated using the box method, as described by Equation 1:

$$Drift = \left(\frac{V_{OUTMAX} - V_{OUTMIN}}{V_{OUT} \times Temp Range}\right) \times 10^{6} (ppm)$$
(1)

The REF50xx features a maximum drift coefficient of 3 ppm/°C for the high-grade version, and 8 ppm/°C for the standard-grade.

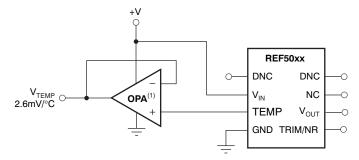
### 7.3.3 Temperature Monitoring

The temperature output terminal (TEMP, pin 3) provides a temperature-dependent voltage output with approximately  $60-k\Omega$  source impedance. As seen in Figure 8, the output voltage follows the nominal relationship:

$$V_{\text{TEMP PIN}} = 509 \text{ mV} + 2.64 \times \text{T}(^{\circ}\text{C})$$
 (2)

This pin indicates general chip temperature, accurate to approximately ±15°C. Although it is not generally suitable for accurate temperature measurements, it can be used to indicate temperature changes or for temperature compensation of analog circuitry. A temperature change of 30°C corresponds to an approximate 79 mV change in voltage at the TEMP pin.

The TEMP pin has high output impedance (see *Functional Block Diagram*). Loading this pin with a low-impedance circuit induces a measurement error; however, it does not have any effect on V<sub>OUT</sub> accuracy. To avoid errors caused by low-impedance loading, buffer the TEMP pin output with a suitable low-temperature drift operational amplifiers, such as the OPA333, OPA335, or OPA376, as shown in Figure 23.



NOTE: (1) Low drift op amp, such as the OPA333, OPA335, or OPA376.

Figure 23. Buffering the TEMP Pin Output

#### 7.3.4 Noise Performance

Typical 0.1-Hz to 10-Hz voltage noise for each member of the REF50xx family is specified in the *Electrical Characteristics: Per Device* table. The noise voltage increases with output voltage and operating temperature. Additional filtering can be used to improve output noise levels, although take care to ensure the output impedance does not degrade performance.

For additional information about how to minimize noise and maximize performance in mixed-signal applications such as data converters, refer to the series of *Analog Applications Journal* articles entitled, *How a Voltage Reference Affects ADC Performance*. This three-part series is available for download from the TI website under three literature numbers: SLYT331, SLYT339, and SLYT355, respectively.



### **Feature Description (continued)**

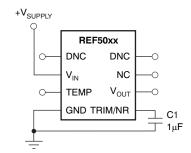


Figure 24. Noise Reduction Using the TRIM/NR Pin

### 7.4 Device Functional Modes

The REF50xx is powered on when the voltage on the  $V_{IN}$  pin is greater than VOUT + 0.2 V, except for the REF5020 and REF5025, where the minimum supply voltage is 2.7 V. The maximum input voltage for the REF50xx is 18 V. Use a supply bypass capacitor ranging from 1  $\mu$ F to 10  $\mu$ F. The total capacitive load at the output must be between 1  $\mu$ F to 50  $\mu$ F to ensure best output stability.



## 8 Application and Implementation

#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 8.1 Application Information

The REF50xx devices are low-noise, precision bandgap voltage references that are specifically designed for excellent initial voltage accuracy and drift. View the *Functional Block Diagram* of the REF50xx.

When designing circuits with a voltage reference, output noise is one of the main concerns. The main source of voltage noise in the reference voltages originates from the bandgap and output amplifier, which contribute significantly to the overall noise. During the design process, it is important to minimize these sources of voltage noise.

### 8.2 Typical Applications

#### 8.2.1 Negative Reference Voltage

For applications requiring a negative and positive reference voltage, the REF50xx and OPA735 can be used to provide a dual-supply reference from a 5-V supply. Figure 25 shows the REF5020 used to provide a 2.5-V supply reference voltage. The low-drift performance of the REF50xx complements the low offset voltage and zero drift of the OPA735 to provide an accurate solution for split-supply applications. Care must be taken to match the temperature coefficients of  $R_1$  and  $R_2$ .

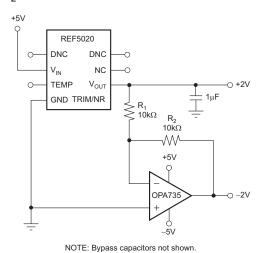


Figure 25. The REF5020 and OPA735 Create Positive and Negative Reference Voltages

### 8.2.1.1 Design Requirements

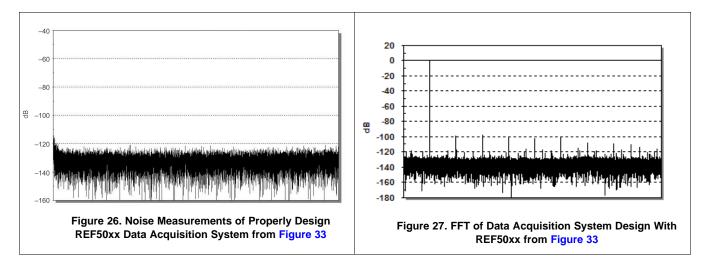
When using REF50xx in the design, it is important to select proper capacitive load that will not create gain peaking adding noise to the output voltage. At the same time, the capacitor must be selected to provide required filtering performance for the system. In addition, input bypass capacitor and noise reduction capacitors must be added for optimum performances.

#### 8.2.1.2 Detailed Design Procedure

Proper design procedure will require first to select output capacitor. If the ESR of the capacitor is not in  $1-\Omega$  range additional resistor must be added in series with the load capacitor. Next, add a  $1-\mu F$  capacitor to the NR pin to reduce internal noise of the REF50xx. Measuring output noise will confirm if the design has met the initial target.

### **Typical Applications (continued)**

#### 8.2.1.3 Application Curves



#### 8.2.2 Positive Reference Voltage

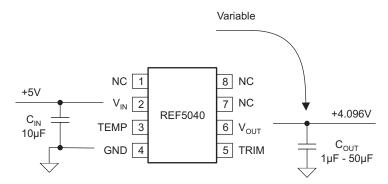


Figure 28. REF50xx With Load Capacitor

#### 8.2.2.1 Detailed Design Procedure

#### 8.2.2.1.1 Load Capacitance

To determine how much noise the reference voltage is contributing in a real application, this design uses the circuit presented in Figure 28. For the same conditions as power supply, input decoupling, and load current, measure the output noise for different output decoupling or load capacitors. The load capacitor type will change the low-pass filter frequency that is created on the output. This filter is determined by an added capacitor value and two parasitic components: the open-loop output impedance of the internal amplifier to the reference voltage, and the ESR of the external capacitor.

Figure 29 shows a fast-Fourier-transform (FFT) plot of the output signal of the reference voltage circuit with a 10- $\mu$ F ceramic capacitor load. The output noise level peaks at around 9 kHz because of the response of the internal amplifier of the circuit to the capacitive load ( $C_1$ ).

This peaking is the main contributor to the overall measured noise. This output noise, measured with an analog meter over a frequency range of up to 80 kHz, is approximately 16.5  $\mu$ VRMS. If the voltage-reference circuit was connected to the input of an ADC, the measured noise across a 65-kHz frequency range would be 138  $\mu$ VPP. This noise level makes this solution adequate for 8- to 14-bit converters.



## **Typical Applications (continued)**

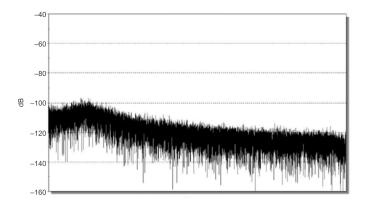


Figure 29. REF50xx FFT Plot of the Noise With 10-μF Load Capacitor and 10-μΩ ESR

Every capacitor can be represented with a complicated equivalent model, which is voltage and frequency dependent with a large number of passive components. For the purposes of this design, this model is limited to the few components. The biggest impact on the creation of the low-pass filter and stability analysis is the simplified model of equivalent series inductance and resistance. Considering good layout practice and inherently low equivalent series inductance of today's components, this model in the future analysis will be presented only by equivalent capacitance and series resistance.

$$f_{P} = \frac{1}{2\pi \cdot (R + ESR) \cdot C_{L}}$$

$$f_{Z} = \frac{1}{2\pi \cdot ESR \cdot C_{L}}$$

Figure 30. Equivalent SCH Of REF50xx With Load Capacitor for Stability Analysis

When evaluating the impact of ESR and  $C_L$  on the performance the reference voltage, it is important to include the effect of the open-loop output resistance ( $R_O$ ) of the output amplifier. The combination of  $R_O$ , ESR, and  $C_L$  modifies the open-loop response curve by introducing one pole ( $f_P$ ) and one zero ( $f_Z$ ). The values  $R_O$ , ESR, and  $R_C$  determine the corner frequency of the added pole  $R_C$  and the values of ESR and  $R_C$  determine the corner frequency of the added zero.

The introduction of the external ESR-CL on the output of the reference voltage modifies the output amplifier open-loop gain curve. The added pole modifies the open-loop gain curve of the reference voltage output amplifier by introducing a -20 dB/decade change at the frequency  $f_P$  to the already -20 dB/decade slope of the open-loop gain curve, making the slope equal to -40 dB/decade. The added zero at frequency  $f_Z$  changes the open-loop gain curve back to -20 dB/decade.



### **Typical Applications (continued)**

**Table 1. Noise Measurement Results for Different Load Capacitors** 

NOISE	22 kHz LP-5P	30 kHz LP-3P	80 kHz LP-3P	>500 kHz	UNIT
GND	0.8	1	1.8	4.9	
1 µF	37.8	41.7	53.7	9,017	
2.2 µF (cer)	41.7	46.2	55.1	60.8	
10 μF	33.4	33.4	35.2	38.5	$\mu V_{RMS}$
10 μF (cer)	37.1	37.2	37.8	39.1	
20 μF (cer)	33.1	33.1	33.2	34.5	
47 μF	23.2	23.8	24.1	26.5	

Table 1 shows the measured noise values for different frequency bandwidths as well as different values and types of external capacitors. These measurements show that low-ESR (approximately  $100\text{-m}\Omega$ ) ceramic capacitors tend to increase the noise, compared to normal-ESR (approximately  $2\text{-}\Omega$ ) tantalum capacitors. This tendency is caused by a stability issue with the output amplifier and gain peaking in the amplifier frequency response.

#### 8.2.2.1.2 Bandgap Noise Reduction

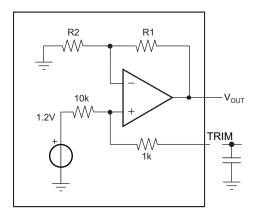


Figure 31. REF50xx Internal Structure of Trim/NR Pin

The internal schematic of the REF50xx device shows that the trim pin allows direct access to the bandgap output. Figure 31 shows the trim pin connection to the internal bandgap circuit through a resistor. Adding a capacitor on the trim pin creates a lowpass filter that has a broadband attenuation of -21 dB.

For example, a small 1-µF capacitor adds a pole at 14.5 Hz and a zero at 160 Hz. If more filtering is needed, a larger value capacitor can be added, which will lower the filter cutoff frequency and the noise contributed by the bandgap.

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Table 2. I	Measured	Noise	$(\mu V_{RMS})$	for	Four	<b>Bandwidths</b>
------------	----------	-------	-----------------	-----	------	-------------------

NOISE	22 kHz (LOW-PASS 5-POLE)	30 kHz (LOW-PASS 3-POLE)	80 kHz (LOW- PASS 3-POLE)	> 500 kHz	UNIT
GND	0.8	1	1.8	4.6	
2.2 µF (ceramic)	42.5	47.2	61.2	68.3	
2.2 μF + 1 μF	17.5	19.4	22.6	24.5	
10 μF (ceramic)	34.4	35.6	37.7	44.5	$\mu V_{RMS}$
10 μF + 1 μF	14.1	14.4	14.9	16.4	
20 μF (ceramic)	34.8	34.9	35.1	35.2	
20 μF + 1 μF	14.4	14.4	14.7	15.1	

Adding a 1-µF capacitor in this example filters the noise contribution of the bandgap and lowers the total noise by a factor of 2.5 times.

### 8.3 System Example

#### 8.3.1 Data Acquisition

Data acquisition systems often require stable voltage references to maintain accuracy. The REF50xx family features low noise, very low drift, and high initial accuracy for high-performance data converters. Figure 32 shows the REF5040 in a basic data acquisition system.

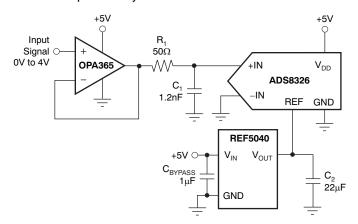


Figure 32. Basic Data Acquisition System

During the design of the data acquisition system, equal consideration must be given to the buffering analog input signal as well as the reference voltage. Having a properly designed input buffer with an associated RC filter is a necessary requirement, but does not ensure the maximum performance.

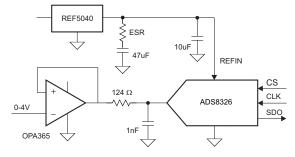


Figure 33. Complete Data Acquisition System Using REF50xx

Three measurements using different components of the output are shown for this data acquisition system.



### **System Example (continued)**

Table 3. Data Acquisition Measurement Results for Different Conditions

OPA365	124 Ω, 1 nF	124 Ω, 1 nF	124 Ω, 100 μF	
REF5040	10 μF	10 μF + 47 μF	10 μF + 47 μF	UNIT
TRIM	0 μF	1 μF	1 μF	
Resolution	16	16	16	Bits
States	65536	65536	65536	
$V_{REF}$	4.096	4.096	4.096	V
LSB	62.5	62.5	62.5	μV
V <sub>IN</sub>	4.02	4.02	4.02	V
Data Std	1.07	0.53	0.41	LSB
Noise	67.0	33.4	25.8	$\mu V_{RMS}$
Noise	442.3	220.5	170.2	$\mu V_{PP}$
SNR	86.7	92.8	95.0	dB
FTT Points	32768	32768	32768	
Noise Flor	-128.8	-134.9	-131.7	dB

Once the correct components for data acquisition system from Figure 33 are selected, measurement results can be compared to the ADS8326 data sheet specifications.

Table 4. AC Performance for Data Acquisition System from Figure 33

	ADS8326	ADS8326B	SYSTEM	SYSTEM	
REF5040	DATA SHEET	DATA SHEET	LOW ESR	10 μF + 47 μF	UNIT
TRIM				1μF	
SNR	91	91.5	90.6	92.2	dB
SINAD	87.5	88	85.7	89.5	dB
SFDR	94	95	88.3	98.4	dB
THD	-90	<b>-</b> 91	-87.3	-92.9	dB
ENOB	14.28	14.35	13.94	14.58	Bits

Table 3 shows improvements on the FFT for a properly designed system.



## 9 Power Supply Recommendations

The maximum voltage drop between the input and output pin is 0.2 V. The minimum power supply voltage for the specific REF50xx device depends on the value of the output voltage, ( $V_{INMIN} = V_{OUT} + 0.2 \text{ V}$ ). The exception to this rule is the REF5020, which requires a minimum 2.7-V power supply for proper operation. The maximum power supply voltage for the REF50xx series is 18 V. TI recommends adding a bypass capacitor of 1  $\mu$ F to 10  $\mu$ F at the input to compensate for the layout and power supply source impedance.

#### 9.1 Basic Connections

Figure 34 shows the typical connections for the REF50xx. TI recommends a supply bypass capacitor ranging from 1  $\mu$ F to 10  $\mu$ F. A 1- $\mu$ F to 50- $\mu$ F output capacitor (C<sub>L</sub>) must be connected from V<sub>OUT</sub> to GND. The ESR value of C<sub>L</sub> must be less than or equal to 1.5  $\Omega$  to ensure output stability. To minimize noise, the recommended ESR of C<sub>L</sub> is between 1  $\Omega$  and 1.5  $\Omega$ .

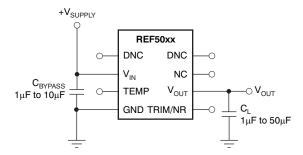


Figure 34. Basic Connections

### 9.2 Low Dropout Voltage

The REF50xx family of voltage references features extremely low dropout voltage. With the exception of the REF5020, which has a minimum supply requirement of 2.7 V, these references can be operated with a supply of 200 mV above the output voltage in an unloaded condition. For loaded conditions, a typical dropout voltage versus load plot is shown in Figure 6 in *Typical Characteristics*.

### 10 Layout

### 10.1 Layout Guidelines

- Place the power-supply bypass capacitor as closely as possible to the VIN pin and ground pins. The recommended value of this bypass capacitor is 1 μF to 10 μF. If necessary, additional decoupling capacitance can be added to compensate for noisy or high-impedance power supplies.
- Place a 1-µF noise filtering capacitor between the NR pin and ground.
- The output must be decoupled with a 1-μF to 50-μF capacitor. In series with load capacitor, add an ESR of 1
  Ω for the best noise performance.
- A high-frequency, 1-µF capacitor can be added in parallel between the output and ground to filter noise and help with switching loads as data converters.

(3)



### 10.2 Layout Example

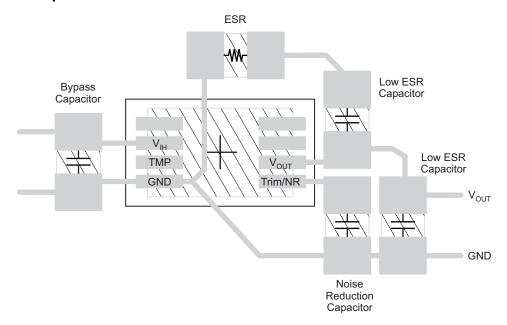


Figure 35. Recommended Layout for REF50xx

## 10.3 Power Dissipation

The REF50xx family is specified to deliver current loads of  $\pm 10$  mA over the specified input voltage range. The temperature of the device increases according to the equation:

$$T_J = T_A + P_D \times R_{\theta JA}$$

#### where

- T<sub>J</sub> = Junction temperature (°C)
- T<sub>A</sub> = Ambient temperature (°C)
- P<sub>D</sub> = Power dissipated (W)
- R<sub>θJA</sub> = Junction-to-ambient thermal resistance (°C/W)

The REF50xx junction temperature must not exceed the absolute maximum rating of 150°C.

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## 11 Device and Documentation Support

### 11.1 Documentation Support

#### 11.1.1 Related Documentation

For related documentation see the following:

- 0.05uV/degC (max), Single-Supply CMOS Zero-Drift Series Operational Amplifier, SBOS282
- REF5020 PSpice Model, SLIM160
- REF5020 TINA-TI Reference Design, SLIM159
- REF5020 TINA-TI Spice Model, SLIM158
- INA270 PSpice Model, SBOM485
- INA270 TINA-TI Reference Design, SBOC246
- INA270 TINA-TI Spice Model, SBOM306

#### 11.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 5. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY		
REF5020-EP	Click here	Click here	Click here	Click here	Click here		
REF5025-EP	Click here	Click here	Click here	Click here	Click here		
REF5040-EP	Click here	Click here	Click here	Click here	Click here		
REF5050-EP	Click here	Click here	Click here	Click here	Click here		

#### 11.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 11.4 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

### 11.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 11.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.



## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

Submit Documentation Feedback





6-Feb-2020

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing		Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
REF5020MDREP	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	5020EP	Samples
REF5025MDTEP	ACTIVE	SOIC	D	8	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	5025EP	Samples
REF5040MDREP	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	5040EP	Samples
REF5050MDREP	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	5050EP	Samples
V62/10613-01XE	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	5020EP	Samples
V62/10613-02XE	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	5040EP	Samples
V62/10613-03XE	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	5050EP	Samples
V62/10613-04XE	ACTIVE	SOIC	D	8	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-2-260C-1 YEAR	-55 to 125	5025EP	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



## PACKAGE OPTION ADDENDUM

6-Feb-2020

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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#### OTHER QUALIFIED VERSIONS OF REF5020-EP, REF5025-EP, REF5040-EP, REF5050-EP:

• Catalog: REF5020, REF5025, REF5040, REF5050

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

## PACKAGE MATERIALS INFORMATION

www.ti.com 26-Sep-2015

## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

All difficultions are norminal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
REF5020MDREP	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
REF5025MDTEP	SOIC	D	8	250	180.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
REF5040MDREP	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
REF5050MDREP	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

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\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
REF5020MDREP	SOIC	D	8	2500	367.0	367.0	35.0
REF5025MDTEP	SOIC	D	8	250	210.0	185.0	35.0
REF5040MDREP	SOIC	D	8	2500	367.0	367.0	35.0
REF5050MDREP	SOIC	D	8	2500	367.0	367.0	35.0



SMALL OUTLINE INTEGRATED CIRCUIT



### NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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